Attorney's Docket No.: 18034-015US1 / 72NP6111 JC20 Rec'd PCT/PTO 12 MAY 2005

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Raffaele Pera et al.

Art Unit : Unknown

Serial No.: Unknown

Examiner: Unknown

Filed

: Herewith

Title

: METHOD AND SYSTEM TO CHECK AN ELECTRONIC METROLOGICAL

MEASUREMENT INSTRUMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request. A copy of a communication from a foreign patent office in a counterpart application is also enclosed.

This statement is being filed with the application. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date:	MAY	12,	2005	
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Substitute Form PTO-1449 (Modified) U.S. Department of Commerce Patent and Trademark Office Information Disclosure Statement by Applicant (Use several sheets if necessary)			Applications 46/9	
		Applicant Raffaele Pera et al.		
		Filing Date Herewith	Group Art Unit	

(37 CFR §1.98(b))

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Trar Yes	nslation No
	AL	2342453	12 April 2000	Great Britain				English
	AM	0736484 A1	09 October 1996	EPO			_	English
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)				
Examiner Initial	Desig. ID	Document		
	AQ	Patent Abstracts of Japan vol. 1995, no. 01, 28 February 1995, JP 06 300603 A (Ricoh Seiki Co Ltd), 28 October 1994.		
	AR	International Search Report for PCT/EP2003/12826 prepared by the European Patent Office on April 7, 2004 and mailed on June 21, 2004.		
	AS			
	AT			

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if no	t in conformance and not considered. Include copy of this form with
next communication to applicant.	Substitute Disclosure Form (PTO-1449)